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# N-Channel 60 V (D-S) MOSFET

| PRODUCT SUMMARY     |                                  |                                    |                       |  |  |
|---------------------|----------------------------------|------------------------------------|-----------------------|--|--|
| V <sub>DS</sub> (V) | $R_{DS(on)}$ (m $\Omega$ )(Typ.) | I <sub>D</sub> (A) <sup>a, e</sup> | Q <sub>g</sub> (Typ.) |  |  |
| 60                  | 1.8 at V <sub>GS</sub> = 10 V    | 180                                | 105 nC                |  |  |
|                     | 2.8 at V <sub>GS</sub> = 4.5 V   | 100                                | 100110                |  |  |

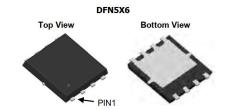
#### **FEATURES**

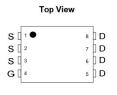
- DT-Trench Power MOSFET
- 100 %  $\rm R_{\rm g}$  and UIS Tested

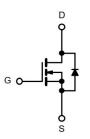


## **APPLICATIONS**

- · Notebook PC Core
- VRM/POL







N-Channel MOSFET

| Parameter  |                                   | Symbol          | Limit                | Unit |  |
|--|-----------------------------------|-----------------|----------------------|------|--|
| Drain-Source Voltage                               |                                   | V <sub>DS</sub> | 60                   | V    |  |
| Gate-Source Voltage                                |                                   | V <sub>GS</sub> | ± 20                 | V    |  |
|  | T <sub>C</sub> = 25 °C            |                 | 180 <sup>a, e</sup>  |      |  |
| Continuous Drain Current (T <sub>J</sub> = 175 °C) | T <sub>C</sub> = 70 °C            | I-              | 160 <sup>e</sup>     | A    |  |
| Continuous Diain Current (1) = 175 C)              | T <sub>A</sub> = 25 °C            | I <sub>D</sub>  | 30 <sup>b, c</sup>   |      |  |
|  | T <sub>A</sub> = 70 °C            |                 | 20 <sup>b, c</sup>   |      |  |
| Pulsed Drain Current                               |                                   | I <sub>DM</sub> | 720                  |      |  |
| Avalanche Current Pulse                            | L = 0.1 mH                        | I <sub>AS</sub> | 175                  |      |  |
| Single Pulse Avalanche Energy                      | L = 0.1 IIII                      | E <sub>AS</sub> | 650                  | mJ   |  |
| Continuous Source-Drain Diode Current              | T <sub>C</sub> = 25 °C            | I <sub>S</sub>  | 180 <sup>a, e</sup>  | А    |  |
| Commudus Gource-Drain Diode Current                | T <sub>A</sub> = 25 °C            | '5              | 4.69 <sup>b, c</sup> |      |  |
|  | T <sub>C</sub> = 25 °C            |                 | 250 <sup>a</sup>     | W    |  |
| Maximum Power Dissipation                          | T <sub>C</sub> = 70 °C            | P <sub>D</sub>  | 175                  |      |  |
|  | T <sub>A</sub> = 25 °C            | ' Б             | 7.5 <sup>b, c</sup>  |      |  |
|  | T <sub>A</sub> = 70 °C            |                 | 5.3 <sup>b, c</sup>  |      |  |
| Operating Junction and Storage Temperature R       | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 150     | °C                   |      |  |

| THERMAL RESISTANCE RATINGS                  |              |                   |         |         |      |  |
|---|--------------|-------------------|---------|---------|------|--|
| Parameter                                   |              | Symbol            | Typical | Maximum | Unit |  |
| Maximum Junction-to-Ambient <sup>b, d</sup> | t ≤ 10 s     | $R_{thJA}$        | 18      | 25      | °C/W |  |
| Maximum Junction-to-Case                    | Steady State | R <sub>thJC</sub> | 0.6     | 0.8     | J    |  |

#### Notes:

- a. Based on T<sub>C</sub> = 25 °C.
  b. Surface mounted on 1" x 1" FR4 board.

- c. t = 10 s.
  d. Maximum under steady state conditions is 90 °C/W.
  e. Calculated based on maximum junction temperature.



| Parameter                                      | Symbol                  | Test Conditions  | Min . | Тур.  | Max.  | Unit  |
|--|-------------------------|--|-------|-------|-------|-------|
| Static   |                         |  |       |       |       |       |
| Drain-Source Breakdown Voltage                 | V <sub>DS</sub>         | $V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$                            | 60    | -     | -     | V     |
| V <sub>DS</sub> Temperature Coefficient        | $\Delta V_{DS}/T_{J}$   | I <sub>D</sub> = 250 μA  | -     | 35    |       | mV/°C |
| V <sub>GS(th)</sub> Temperature Coefficient    | $\Delta V_{GS(th)}/T_J$ | Ι <sub>D</sub> – 250 μΑ  | 1-    | - 5.5 | -1    |       |
| Gate-Source Threshold Voltage                  | V <sub>GS(th)</sub>     | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$                                       | 1.0   |       | 3.0   | V     |
| Gate-Source Leakage                            | I <sub>GSS</sub>        | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$                          | 1     |       | ± 100 | nA    |
| 7 0 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1        | I <sub>DSS</sub>        | V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V                              | -     |       | 1     | μА    |
| Zero Gate Voltage Drain Current                |                         | $V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$ | -     |       | 10    |       |
| On-State Drain Current <sup>a</sup>            | I <sub>D(on)</sub>      | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$                            | 180   |       |       | Α     |
| Drain-Source On-State Resistance <sup>a</sup>  | Ь                       | $V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}$                                | 1     | 1.8   | 2.5   | mΩ    |
|  | R <sub>DS(on)</sub> -   | $V_{GS} = 4.5 \text{ V}, I_D = 30 \text{ A}$                               | -     | 2.8   | 3.6   |       |
| Forward Transconductance <sup>a</sup>          | 9 <sub>fs</sub>         | V <sub>DS</sub> = 5 V, I <sub>D</sub> = 20 A                               | 1     | 110   |       | S     |
| Dynamic <sup>b</sup>                           |                         |  |       |       |       |       |
| Input Capacitance                              | C <sub>iss</sub>        |  | -     | 7080  | -     | pF    |
| Output Capacitance                             | C <sub>oss</sub>        | $V_{DS}$ =30 V , $V_{GS}$ = 0 V, f = 1 MHz                                 | -     | 1440  | -     |       |
| Reverse Transfer Capacitance                   | C <sub>rss</sub>        |  | -     | 3     | -     |       |
| Total Gate Charge                              | Qg                      |  | 1     | 105   | -     | nC    |
| Gate-Source Charge                             | Q <sub>gs</sub>         | $V_{DS}$ = 30 V, $V_{GS}$ = 10 V, $I_{D}$ = 30 A                           | -     | 84    | -     |       |
| Gate-Drain Charge                              | Q <sub>gd</sub>         |  | -     | 16    | -     |       |
| Gate Resistance                                | R <sub>g</sub>          | f = 1 MHz  | -     | 1.5   | 1-    | Ω     |
| Turn-On Delay Time                             | t <sub>d(on)</sub>      |  | -     | 19    | -     |       |
| Rise Time                                      | t <sub>r</sub>          | $V_{DD} = 30 \text{ V}, R_{L} = 0.555\Omega$                               | 1     | 20    | -     | ns    |
| Turn-Off Delay Time                            | t <sub>d(off)</sub>     | $I_D = 30 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1\Omega$                | -     | 31    | -     |       |
| Fall Time                                      | t <sub>f</sub>          |  | 1     | 6     | -     |       |
| <b>Drain-Source Body Diode Characteristics</b> | 3                       |  |       |       | ·     |       |
| Continuous Source-Drain Diode Current          | I <sub>S</sub>          | T <sub>C</sub> = 25 °C   | -     |       | 180   | Α     |
| Pulse Diode Forward Current <sup>a</sup>       | I <sub>SM</sub>         |  | =     |       | 720   |       |
| Body Diode Voltage                             | V <sub>SD</sub>         | I <sub>S</sub> = 20 A  | -     | 0.8   | 1.2   |       |
| V Body Diode Reverse Recovery Time             |                         |  | 1     | 55    | 78    | ns    |
| Body Diode Reverse Recovery Charge             | Q <sub>rr</sub>         | I <sub>F</sub> = 20 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C            | -     | 97    | 170   | nC    |
| Reverse Recovery Fall Time                     | t <sub>a</sub>          | 15 20 M, direct = 100 Mps, 13 = 20 C                                       | -     | 29    |       | ns    |
| Reverse Recovery Rise Time                     | t <sub>b</sub>          |  | -     | 23    |       |       |

### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

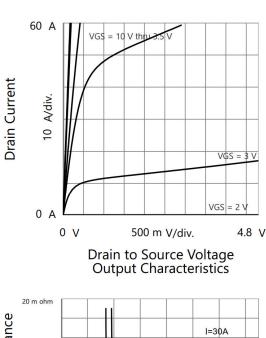
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

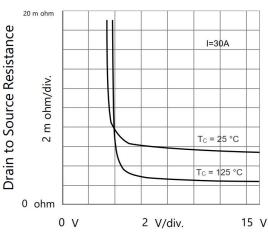
b. Guaranteed by design, not subject to production testing.



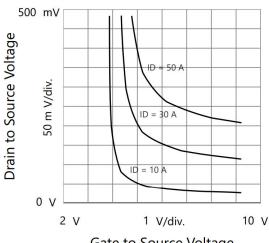


# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

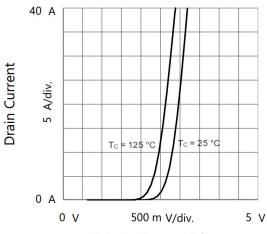




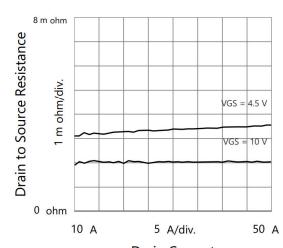
Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage



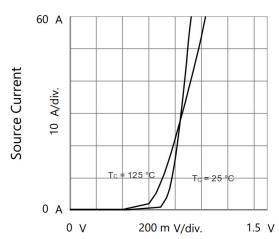




Gate to Source Voltage Transfer Characteristics



Drain Current
Drain to Source Resistance vs. Drain Current

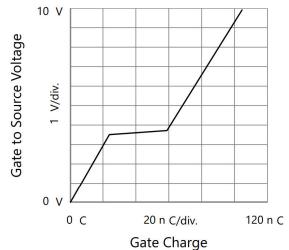


Source to Drain Voltage Body Diode Forward Characteristics

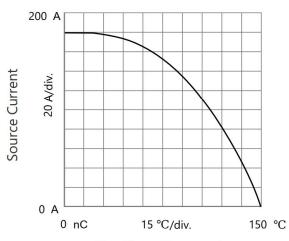


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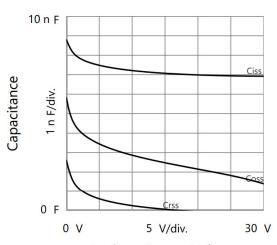


Gate to Source Voltage vs. Gate Charge

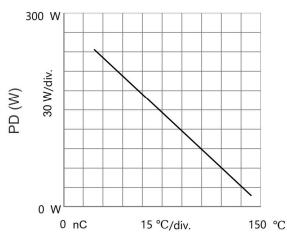


T<sub>C</sub> - Case Temperature

Current Derating

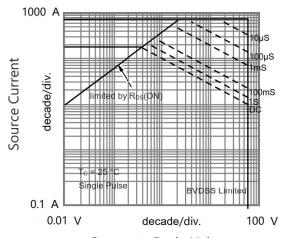


Drain to Source Voltage Capacitances



T<sub>C</sub> - Case Temperature

Power Derating



Source to Drain Voltage Safe Operating Area, Junction-to-Ambient



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